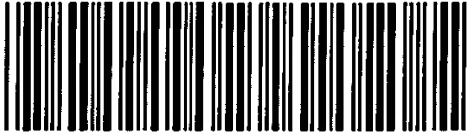


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/921,423	THAKUR ET AL.	
	Examiner	Art Unit	
	Johannes P. Mondt	2826	

SEARCHED			
Class	Subclass	Date	Examiner
257	68, 71	5/27/2005	JPM
257	277	5/27/2005	JPM
257	296, 298	5/27/2005	JPM
257	300, 303	5/27/2005	JPM
257	306, 309	5/27/2005	JPM
257	532, 534	5/27/2005	JPM
257	516, 906	5/27/2005	JPM
257	700-701	5/27/2005	JPM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	306, 309	5/27/2005	JPM
257	296	5/27/2005	JPM
257	532, 534	5/27/2005	JPM

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
All East data bases and IEEE	5/27/2005	JPM